

(PTO-1449)

**U.S. PATENT
APPLICATION NO.
10/795,810**

APPLICANT
Yutaka HIRATA

FILING DATE
March 9, 2004

**GROUP
3636**

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	DE 196 46 480A1	05/14/1998	Germany				X
	DE 196 52 976A1	06/04/1998	Germany				X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION
(PTO-1449)

ATTY. DOCKET NO.
K-1746RE

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	4,865,379	09/12/1989	Aoki et al			02/04/1988

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	S62-290413	12/17/1987	Japan				X
	H 09-182647	07/15/1997	Japan			X	
	U-S49-132105		Japan				X
	U-S57-27961		Japan				X
	U-S63-54213	04/12/1988	Japan				X
	H01-160747	06/23/1989	Japan			Abstract	
	H05-115330	05/14/1993	Japan			X	
	U-S63-99557	06/28/1988	Japan				X
	U-S63-31851	03/01/1988	Japan				X
	H03-500108	01/10/1991	Japan (PCT)				X
	H09-182647	07/15/1997	Japan			X	
	U-S55-143761		Japan				X
	U-S63-99557	06/28/1988	Japan				X
	H05-57069	03/09/1993	Japan			X	

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